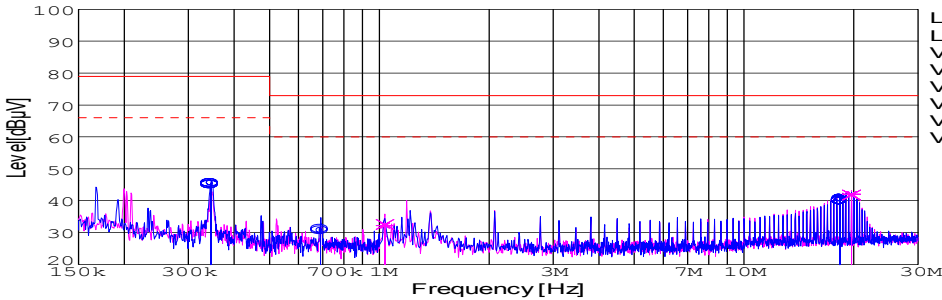
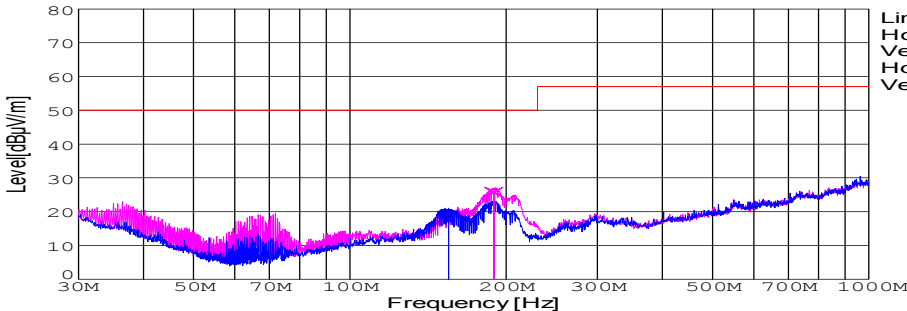


DATA SHEET							Date	18-Feb-05		
Model	SUCS60512						Temp.	25 degreeC		
Test	EMI Line conduction & Radiated emission						Humid.	45 %RH		
							Tested by	Y.Hirose		
LINE CONDUCTION										
Model Name : SUCS60512			Temp. : 25							
Model No. :			Humi. : 45							
Serial No. :			Date : 2005/2/18 16:11							
Points : 5			Test Equip. : R3132,ESPC							
Detector : PEAK/QP/Ave.			Comment : Y.Hirose							
Line Mode : VA/VB										
Power Supply : DC 5V										
Limit1: [EN 55022] Class A(QP)										
Limit2: [EN 55022] Class A(Ave.)										
							Limit1(QP) Limit2(Ave.) VA(PEAK) VB(PEAK) VA(QP) VA(Ave.) VB(QP) VB(Ave.)			
							DC 5V 12V0.5A			
Frequency [MHz]	Meter Reading (Ave.) [dBuV]	Meter Reading (QP) [dBuV]	Factor [dB]	Level(Ave.) [dBuV]	Level(QP) [dBuV]	Line	Limit(Ave.) [dBuV]	Limit(QP) [dBuV]	Margin(Ave.) [dB]	Margin(QP) [dB]
0.345	35.8	35.4	9.8	45.6	45.2	VA	66	79	20.4	33.8
0.69	20.8	21.3	9.9	30.7	31.2	VA	60	73	29.3	41.8
18.3086	30.2	29.9	10.2	40.4	40.1	VA	60	73	19.6	32.9
1.0373	22.3	22.7	9.9	32.2	32.6	VB	60	73	27.8	40.4
19.6873	31.8	31.5	10.3	42.1	41.8	VB	60	73	17.9	31.2
RADIATED EMISSION										
Model Name : SUCS60512			Temp. : 25							
Model No. :			Humi. : 45							
Serial No. :			Date : 2005/2/21 18:42							
Points : 2			Test Equip. : R3132,ESPC							
Detector : PEAK/QP			Comment : Y.Hirose							
Polarization : Hori. & Vert.										
Power Supply : DC 5V										
Limit: [EN 55022] Class A<3m>										
							Limit(QP) Horizontal(PEAK) Vertical(PEAK) Horizontal(QP) Vertical(QP)			
							DC 5V 12V0.5A			
Frequency [MHz]	MeterReading (QP) [dBuV]	Ant. Type	Antenna Factor [dB/m]	Cable & Preamp [dB]	Level(QP) [dBuV/m]	Angle [°]	Height [cm]	Polar.	Limit [dBuV/m]	Margin [dB]
154.83	40.6	BL	10.3	-31.5	19.4	208	158	Hori.	50	30.6
189.484	48.8	BL	8.3	-31.3	25.8	349	109	Vert.	50	24.2

# COSEL

## Conditions

Test : EMI  
Model Name : SUCS/SUCW 605□□

○Photographs of Test Set-Up

### LINE CONDUCTION



### RADIATED EMISSION



○Testing circuitry

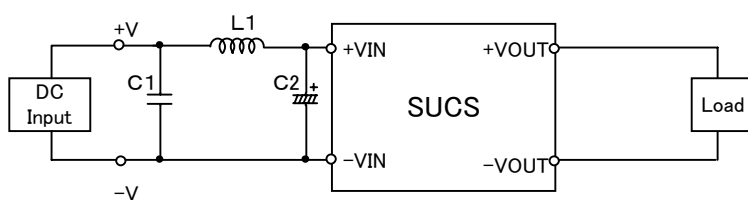


Fig.1 Testing circuitry 1

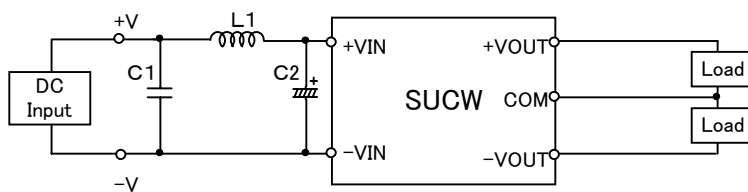


Fig.2 Testing circuitry 2

L1 :	0.5 $\mu$ H	CY3H-R50	(KORIN ELECTRONICS)
C1 :	25V    2.2 $\mu$ F	C3216JB1E225M	(TDK)
C2 :	16V    470 $\mu$ F	LXZ16VB470(M)	(NIPPON CHEMI-COM)